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Permalink
https://escholarship.org/uc/item/7kn666x6

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Publication Date
2019-07-01

DOI
10.1016/j.ensm.2018.11.026

Peer reviewed
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ABSTRACT

Understanding interactions at the interfaces of carbon with ionic liquids (ILs) is crucially beneficial for the diagnostics and performance improvement of electrochemical devices containing carbon as active materials or conductive additives in electrodes and ILs as solvents or additives in electrolytes. The interfacial interactions of three typical imidazolium-based ILs, 1-alkyl-3-methylimidazolium bis(trifluoromethanesulfonyl)imide (AMImTFSI) ILs having ethyl (C₂), butyl (C₄) and octyl (C₈) chains in their cations, with highly oriented pyrolytic graphite (HOPG) were studied in-situ by electrochemical scanning tunneling microscopy (EC-STM). The etching of HOPG surface and the exfoliation of graphite/graphene flakes as well as cation intercalation were observed at the HOPG/C₂MImTFSI interface. The etching also takes place in C₄MImTFSI at -1.5 V vs Pt but only at step edges with a much slower rate, whereas C₈MIm⁺ cations adsorbs strongly on the HOPG surface under similar conditions with no observable etching or intercalation. The EC-STM observations can be explained by the increase in van der Waals interaction between the cations and the graphite surface with increasing length of alkyl chains.
**Keywords:** Electrochemical scanning tunneling microscope; ionic liquids; imidazolium; graphite
1. INTRODUCTION

Ionic liquids (ILs) are molten salts near room temperature composed of anions and cations sterically mismatched. In recent years, ILs have been used as electrolytes in energy storage devices such as batteries and supercapacitors,\(^1-3\) thanks to their superior ionic conductivity, and good thermal and chemical stability. ILs are also introduced as additives in conventional carbonate-based electrolytes to improve the cycling stability and safety of rechargeable cells.\(^4-8\) The most commonly used ILs in the electrochemical energy storage devices are those containing alkylammonium,\(^9-11\) N-alkylpyrroolidinium,\(^4, 8\) and N,N’-dialkylimidazolium\(^12-15\) cations with alkyl chains of different length attached to the N atoms in the alkylammonium or aromatic rings.\(^16\)

Carbon materials have been extensively used in electrochemical energy storage devices, primarily as electrode materials, for instance, graphite anode in lithium ion batteries (LIBs),\(^17\) and porous carbon electrode in supercapacitors.\(^18, 19\) The interaction between ILs and carbon materials including adsorption, etching, and intercalation may greatly influence the performance of relevant devices. The adsorption process of IL ions on carbon materials, for example, determines the capacitive behavior in electric double layer capacitors. The cation intercalation and cathodic etching at the graphite/IL interface can potentially interfere with the intercalation of lithium ions in LIBs. Understanding these interfacial processes is therefore crucially
beneficial for the diagnostics and performance improvement of relevant energy storage devices.

The structure of IL adsorption layer on graphite has been previously studied by both theory\textsuperscript{1} and different experimental techniques such as scanning probe microscopy,\textsuperscript{20} sum frequency generation,\textsuperscript{21} high energy X-ray reflectivity.\textsuperscript{22} It was found that the adsorption behavior of IL on graphite surface highly depends on the chemical structure of both cations and anions. X-ray diffraction (XRD) experiments confirmed the occurrence of intercalation of imidazolium or pyrrolidinium cations into graphite, where the N-containing rings of the cations align parallel to the graphene sheets and expand the graphite interlayer distance from 0.34 nm to 0.7 ~ 0.8 nm.\textsuperscript{12, 14, 23, 24} Although the anodic etching of graphite by electrochemical oxidation has been well documented,\textsuperscript{25-28} there are very few reports on the cathodic etching of graphite in ILs, among which is the STM study by Hu et al.\textsuperscript{4}, where cathodic etching of HOPG in N-methyl-N-propylpyrrolidinium bis(trifluoromethanesulfonyl)imide (Py\textsubscript{13}TFSI) was observed and attributed to the decomposition of the TFSI\textsuperscript{-} anions.

Electrochemical scanning tunneling microscopy (EC-STM) is a powerful in-situ technique for the characterization of solid/liquid interface under different potentials, including the interface between ILs and carbon materials such as highly oriented pyrolytic graphite (HOPG) or graphene.\textsuperscript{4, 29} Herein, we report an EC-STM study on the adsorption, intercalation, and etching behavior of imidazolium-based ILs under open circuit potential (OCP) and cathodic
potentials at HOPG/IL interface and their dependence on the length of the alkyl chains in the aromatic cations.

2. EXPERIMENTAL

2.1. Materials

1-Ethyl-3-methylimidazolium bis(trifluoromethanesulfonyl)imide (C_2MImTFSI) and 1-Octyl-3-methylimidazolium bis(trifluoromethanesulfonyl)imide (C_8MImTFSI) both with 99.6% purity were purchased from Ionic Liquids Technologies (Io-Li-Tec, Germany). 1-Butyl-3-methylimidazolium bis(trifluoromethanesulfonyl)imide (C_4MImTFSI) with 98% purity was purchased from Sigma-Aldrich. The ILs used in this study all have the same anion and imidazolium cations, differing only in the alkyl chain length attached to the aromatic ring. Prior to electrochemical and STM experiments, the ILs were dried at 120 °C in a vacuum chamber to minimize the amount of water and oxygen contaminant in the IL. The HOPG (B-grade) sample obtained from the Institute of Metal Research, Chinese Academy of Sciences, was freshly cleaved for each set of electrochemical and STM experiments.

2.2. Electrochemical measurements

Cyclic voltammetry (CV) measurements were carried out inside an argon glove box using an Autolab PGSTAT 302N potentiostat with three-electrode control. The HOPG working electrode, with a diameter of 3 mm, was mounted
on a cylindrical hollow PEEK holder and sealed with a Viton ring. The counter and pseudo-reference electrodes were both made of Pt wires with diameters of 0.25 mm. All CV measurements started in the cathodic sweeping direction from OCP to -1.8 V vs Pt. Because all the STM experiments started on a freshly cleaved HOPG surface with no electrochemical pre-treatments, given the changes of HOPG surface observed in some STM measurements, only the first cycle of CV measurements was reported and discussed here.

2.3. EC-STM measurements

EC-STM measurements were performed using a Beetle-style scan-head and SPM100 controller from RHK Technology, with the scanner mounted on top of a home-built electrochemical cell inside a sealed nitrogen chamber. Platinum wires were also used as both counter and pseudo-reference electrodes in STM experiments. A bipotentiostat (Pine Instrument Company, Model AFCBP1) was used to simultaneously control the sample potential and the bias voltage between sample and tip. Figure 1 shows a schematic diagram of the EC-STM setup. The imaging parameters: $V_t = V_{\text{sample}} - V_{\text{tip}}$, and $I_t$, are indicated in the figure captions. STM tips were prepared by electrochemically etching a Pt-Ir wire (0.25 mm in diameter), which was subsequently coated with Apiezon wax, except a few $\mu$m near the apex. Such coating step was necessary to minimize spurious currents from the solution background (compared to typically 10 pA tunneling current).
3. RESULTS AND DISCUSSION

3.1. Cyclic voltammetry

Figure 2 shows the first-cycle CV curves of HOPG electrode in all three ILs. The molecular structures of these ILs are illustrated in the insets. For C\textsubscript{2}MImTFSI, a sharp increase in the cathodic current below -1.65 V vs Pt indicates the onset of massive cation decomposition and possibly simultaneous cation intercalation.\textsuperscript{31} The cathodic peak at -0.9 V vs Pt, marked as C2a in Figure 2a, can be attributed to the reduction of water and oxygen residuals in the ILs, according to the electrochemical study by Randstrom et al.\textsuperscript{31} The distinct feature seen at -1.78 V vs Pt in the anodic sweep, marked as A2, is possibly related to the de-intercalation of surviving cations.\textsuperscript{4, 12} For C\textsubscript{4}MImTFSI and C\textsubscript{8}MImTFSI, similar impurity-related anodic peaks, marked as C4a and C8a respectively, can be seen between -0.9 and -
1.0 V vs Pt. In both cases however only mild increase in the cathodic current was observed beyond the C4a/C8a peaks and no anodic features related to the de-intercalation were present in the anodic sweep.

Another important observation is the color change in the C₂MImTFSI ILs, from initially colorless to brown when the potential was held at -2.0 V vs Pt. Such color change is due to the graphene sheets and/or graphite flakes detached from the HOPG surface and then dispersed in the bulk IL, as will be demonstrated later in the STM experiments. No such color change was observed in the C₄MImTFSI and C₈MImTFSI.

Figure 2. First-cycle CV curves of HOPG electrodes: (a) in C₂MImTFSI, (b) in C₄MImTFSI, and (c) in C₈MImTFSI, acquired with a scanning rate of 5 mV/s. The molecular structures of C₂MIm⁺ and TFS⁻, C₄MIm⁺, C₈MIm⁺ are shown as insets, where H, C, N, O, F and S atoms are shown in gray, cyan, blue, red, ochre, and yellow, respectively.

3.2. Adsorption of C₂,4,8MImTFSI on HOPG

In C₂MImTFSI under OCP at low tunneling resistance (Vₜ = 50 mV, Iₜ = 50 pA), the STM image, shown in Figure 3a, reveals only the structure of clean graphite with no features related to the adsorption of either ion. This is in
contrast with intermittent-contact mode AFM results which suggest co-adsorption of cations and anions with well-defined structures on the HOPG surface. The absence of IL-related features in our STM results is likely due to the weak adsorption of both ions at OCP and the close proximity of the tip to the surface that causes displacement of the molecular layer. In intermittent AFM contact mode, however, the dragging force to displace the molecules is much lower. After a factor 3 increase in tunneling resistance ($V_t = 500$ mV, $I_t = 150$ pA), which corresponds to an approximately 50 pm larger tip-surface separation, the adsorbed molecules could be sensed, evidenced by the presence of streaks in the image as shown in Figure 3b, resulting from the tip dragging the molecules. Operating at even bigger tip-sample distances was not possible owing to the tip instability at higher tip voltages. Increasing the electrostatic force between molecules and surface can potentially help to hold down the ions, but -1.5 V vs Pt, the lowest potential we tested here, is still not sufficient to immobilize the ions and no specific structure was observed, as shown in Figure 3c. Similar phenomena were observed at the HOPG/C₄MImTFSI interface.
Figure 3. EC-STM images of the HOPG surface (a, b) in C$_2$MImTFSI under open cell potential, (c) in C$_2$MImTFSI under -1.5 V vs Pt, (d) in C$_8$MImTFSI under -1.5 V vs Pt. The insert in (d) is a corresponding Fast Fourier Transfer (FFT) image. Imaging parameters: (a) V$_t$ = 50 mV, I$_t$ = 50 pA; (b-d) V$_t$ = 500 mV, I$_t$ = 150 pA. Image sizes: (a, b) 6 × 3 nm$^2$; (c) 30 × 30 nm$^2$; (d) 40 × 40 nm$^2$.

In the case of C$_8$MImTFSI however, a periodic superstructure with 4-fold symmetry and 1.5 nm period was observed after 130 min scanning at -1.5 V vs Pt, as shown in Figure 3d. At such negative potentials, the first layer should be almost exclusively comprised of cations, as suggested by molecular dynamic simulations$^{33, 34}$ and AFM studies.$^{32, 35, 36}$ The observation of the undisturbed superstructure indicates the stronger interaction of C$_8$MIm$^+$ cations with HOPG substrate compared to C$_2$MIm$^+$ and C$_4$MIm$^+$, such that the adsorbed C$_8$MIm$^+$ cations now cannot be displaced by the STM tip. Given the structure difference in these three cations, we can attribute the increase in the adsorption strength to the stronger van der Waals (vdW) interaction of the cations with longer alkyl chains at the HOPG surface.$^{37, 38}$ The period of 1.5 nm is slightly smaller than the length of the C$_8$MIm$^+$ cation (~1.7 nm), suggesting that the alkyl chains of the cations lie almost parallel to the HOPG surface possibly with some overlap between neighboring alkyl chains.

It is worth pointing out that such self-assembly is actually a slow and dynamic process, possibly because of the high viscosity of ILs. As observed by Carstens et al.$^{29}$, the superstructure formed at HOPG/C$_8$MImTFSI interface keeps evolving in consecutive STM scans even when the potential was held.
constant. This may explain why the superstructure we observed when holding the potential at -1.5 V for 130 min is different from the reported by Carstens et al.

3.3. Cathodic etching of the graphite surface in $C_{2,4,8}$MImTFSI

Because the ions are too mobile at HOPG/$C_{2,4,8}$MImTFSI interfaces and cannot be detected by STM, we examined in more detail the changes on the HOPG surface itself under different potentials. The STM images acquired in $C_{2}$MImTFSI (Figure 4) show rapid morphological change on the HOPG surface, already observable at potential as low as -0.5 V vs Pt. In the consecutive images acquired at -0.5 V vs Pt (Figure 4a-d), the formation of graphite flakes can be seen, typically starting at step edges (one example marked in white dashed line). These flakes are mobile and, together with the mobile ions, contribute to the streaks observed in the images.
Figure 4. Time-lapse EC-STM images of the HOPG surface in C$_2$MImTFSI at (a-d) -0.5 V, (e-h) -1.0 V and (i-l) -1.5 V vs Pt. Imaging parameters: (a-h) $V_t = 500$ mV, $I_t = 250$ pA; (i-l) $V_t = 500$ mV, $I_t = 200$ pA. Image sizes: (a-h) 200 × 200 nm$^2$; (i-l) 250 × 250 nm$^2$. White dashed lines mark the graphite step edges where exfoliation and detachment of flakes were initiated. The blue arrows in (k) and (l) highlight some detached flakes. The insets in (e) and (h) show the height profiles along the black arrows in the corresponding images.
At -1.0 V vs Pt, cracking of HOPG surface and removal of two large flakes (marked 1 and 2 in Figure 4e) can be seen in consecutive images in Figure 4e-h. The initial trench in Figure 4e (at the center of the black arrow; 3.1 nm in depth) eventually evolved into a step edge of 3.6 nm in height after 15 min as shown in Figure 4h, while the graphite flake 2 on the right completely disappeared from the scan range. An even lower potential of -1.5V vs Pt leads to more severe surface cracking and exfoliation, producing more mobile graphite flakes, as can be seen in Figure 4i-k.

Similar STM experiments were performed in C₄MImTFSI and C₈MImTFSI. Unlike the case of C₂MImTFSI, neither severe cracking nor rapid exfoliation was observed in both ILs with longer alkyl chains. In C₄MImTFSI, instead we observed a very slow recession of external step edges (marked by white dashed line in Figure 5), at both -0.5 V (Figure 5a and b) and -1.5 V vs Pt (in a different area of the surface; Figure 5c and d). Some of the observed steps (marked in blue in Figure 5a and b) are internals steps (graphene flakes buried under the top layers)³⁹, which are not accessible from the solution and remained unchanged. The cross-edge profile along the arrow in Figure 5d, shows that the step height remains constant at 0.34 nm (the spacing between consecutive graphene layers), indicative of no intercalation of C₄MIm⁺ cations between the graphene sheets.
Figure 5. Time-lapse EC-STM images of the HOPG surface in C₄MImTFSI at (a, b) -0.5 V and (c, d) -1.5 V vs Pt. Imaging parameters: $V_t = 50$ mV, $I_t = 100$ pA. Image sizes: (a, b) 500 × 500 nm²; (c, d) 50 × 50 nm². The initial positions of external step edges in (a) and (c) are marked with white dashed lines to help to visualize the changes with time. Internal step edges are marked in blue lines. The inset of (d) shows the height profile along the black arrow.

In C₈MImTFSI, we did not observe obvious step edge recession even at -1.5 V vs Pt, as shown in Figure 6. The height profile across the step edge marked by the black arrow remained unchanged after 15 min. The step height between the left and right flat areas is 0.47 nm, slightly larger than the distance between graphene sheets in HOPG (0.34 nm) but not enough to accommodate the C₈MIm⁺ cations. The small jump in height (0.67 nm) right
at the edge can be caused by folded edge and/or by multiple images due to double-tip or even triple-tip asperities in this particular experiment.

![Time-lapse EC-STM images of the HOPG surface in C₈MImTFSI acquired at -1.5 V vs Pt. Imaging parameters: Vᵋ = 500 mV, Iᵋ = 50 pA. Image sizes are both 100 × 100 nm². A multiple tip effect is present in these images that produces 3 or more ghost images of the step edge. The insets in (a) and (b) show the height profiles along the black arrows in corresponding images.](image)

**Figure 6.** Time-lapse EC-STM images of the HOPG surface in C₈MImTFSI acquired at -1.5 V vs Pt. Imaging parameters: Vᵋ = 500 mV, Iᵋ = 50 pA. Image sizes are both 100 × 100 nm². A multiple tip effect is present in these images that produces 3 or more ghost images of the step edge. The insets in (a) and (b) show the height profiles along the black arrows in corresponding images.

### 3.4. Dependence of etching rate on the length of alkyl chains

Given the similarity in the molecular structure of these three ILs, it is reasonable to expect a similar chemical origin of any chemical attack of the graphite by the ILs. According to Hu et al.⁴, such cathodic etching is induced by anion TFSI⁻ decomposition, which can be further catalyzed by the reduction products of water/oxygen impurities.³¹ However, our STM results show a clear dependence of the etching rate on the length of the alkyl chains. Based on the very different adsorption behavior observed in our STM
results, we can conclude that the adsorption strength of cations due to their different alkyl chains plays a crucial role in the etching process.

For the smallest cation $\text{C}_2\text{MIm}^+$, its adsorption on the graphite surface is the weakest among the three. As a result, the $\text{C}_2\text{MIm}^+$ cations are highly mobile, easily displaced by STM tips and thus cannot be detected by STM. Such high mobility of cations at the interface makes it easier for TFSI$^-$ anions or water/oxygen impurities to approach the graphite surface and decompose there, eventually causing the cathodic etching of graphite. The anodic de-intercalation peak (A2) observed in the CV curve points toward the occurrence of cation intercalation. Simultaneous etching and intercalation lead to rapid formation and detachment of graphite/graphene flakes from the HOPG surface in $\text{C}_2\text{MImTFSI}$ as we observed in the STM experiments, which also explains the color change of the $\text{C}_2\text{MImTFSI}$ IL when the potential was held at -2.0 V vs Pt.

Spontaneous cation intercalation and subsequent exfoliation at OCP has been observed by Atkins et al. in $\text{C}_2\text{MImAc}$ and $\text{C}_2\text{MImTFMS}$,\textsuperscript{40} while the spontaneous exfoliation was not observed in $\text{C}_2\text{MImTFSI}$ by these authors. The vdW interaction between graphene sheets can prevent them from sliding,\textsuperscript{41} as well as exfoliating. But the electric field at sufficiently high negative potentials can drive the $\text{C}_2\text{MIm}^+$ cations in between graphite layers, especially through the etching cracks on the surface, then triggering the exfoliation.
For the cations with longer alkyl chains, C₄MIm⁺ and C₈MIm⁺, the stronger vDW interaction with the graphite surface makes them adsorb more strongly compared to C₂MIm⁺, leading to the formation of the superstructure observed at C₈MImTFSI/HOPG interface. Stronger adsorption on the graphite surface will certainly reduce the mobility of the interfacial cations, impede the decomposition of TFSI⁻ or impurities at the interface and consequently slow down the etching process. Indeed, instead of rapid exfoliation and intercalation, only slow recession of step edges was observed in C₄MImTFSI and no obvious change at HOPG/C₈MImTFSI interface. The stronger adsorption also seems to impact the intercalation behavior of the cations. The absence of anodic peaks in the CV curves of the two longer chain ILs, like the A2 peak in the CV curve of C₂MImTFSI, supports no or minimal intercalation at least down to -1.8V vs Pt, in line with the lack of any observed change in height with time in the STM images for C₄MImTFSI and C₈MImTFSI.

4. CONCLUSIONS

We studied the interaction of C₂,₄,₈MImTFSI with HOPG surface at OCP and cathodic conditions using EC-STM. It was found that the adsorption strength of the cations increases with the length of the alkyl chains because of increasing vDW interaction. The difference in adsorption strength has an important impact on the mobility of the cations at the HOPG/IL interfaces and consequently alters the rate of cathodic etching on graphite surface, leading to drastically different surface modifications in three ILs: etching and
exfoliation in C$_2$MImTFSI, slow step edge recession in C$_4$MImTFSI, and no observable change in C$_8$MImTFSI. Our results provide useful insights to help understand the mechanism of carbon/IL interfacial processes as well as diagnose the performance of electrochemical devices containing carbon as active materials or conductive additives in electrodes and ILs as solvents or additives in electrolytes.

ACKNOWLEDGEMENTS

This work was supported by the Office of Basic Energy Sciences (BES), Division of Materials Sciences and Engineering, of the U.S. Department of Energy (DOE) under Contract DE-AC02-05CH11231, through the Structure and Dynamics of Materials Interfaces program (FWP KC31SM). H.W., B.F. and H.-T. F. acknowledge the support from Harbin Institute of Technology through the Short-term Visiting Program and Natural Scientific Research Innovation Foundation (Grant no. 30620160007) and by the National Natural Science Foundation of China (Grant no. 51272051, 50872026). B.E. acknowledges financial support from the Swiss National Science Foundation (SNF) through Early Postdoctoral Mobility fellowship.

Data Availability

The raw data and processed data required to reproduce these findings are available to download from http://dx.doi.org/10.17632/brkjgjd234.1.
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